

Low ohmic measurements (comparison Euromet.EM-S22)

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NMi VSL and NPL



Outline

- Background
- VSL measurement set-up
 - Schematic
 - Uncertainty
- NPL set-up
 - Schematic
 - Uncertainty
- Comparison
 - Aim & Protocol
 - Results
 - Preliminary conclusion
- Outlook / discussion



Low ohmic measurements

Applications:

- Shunts – large currents / energy
- Reference for cable manufacturers

Traditional setup:

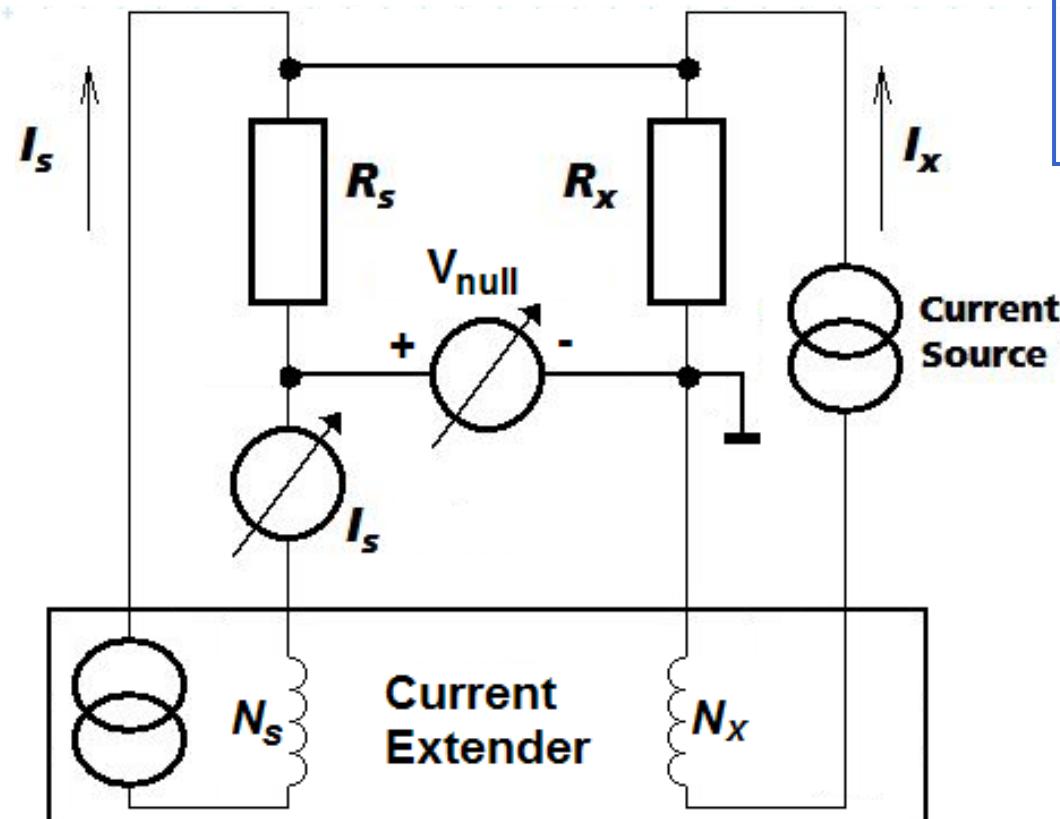
GL9920 with range extender

- time consuming (drifts, power effects)
- 'reliable' accuracy?
- limited insight in the process

Comparisons of the past 20 years?

VSL set-up

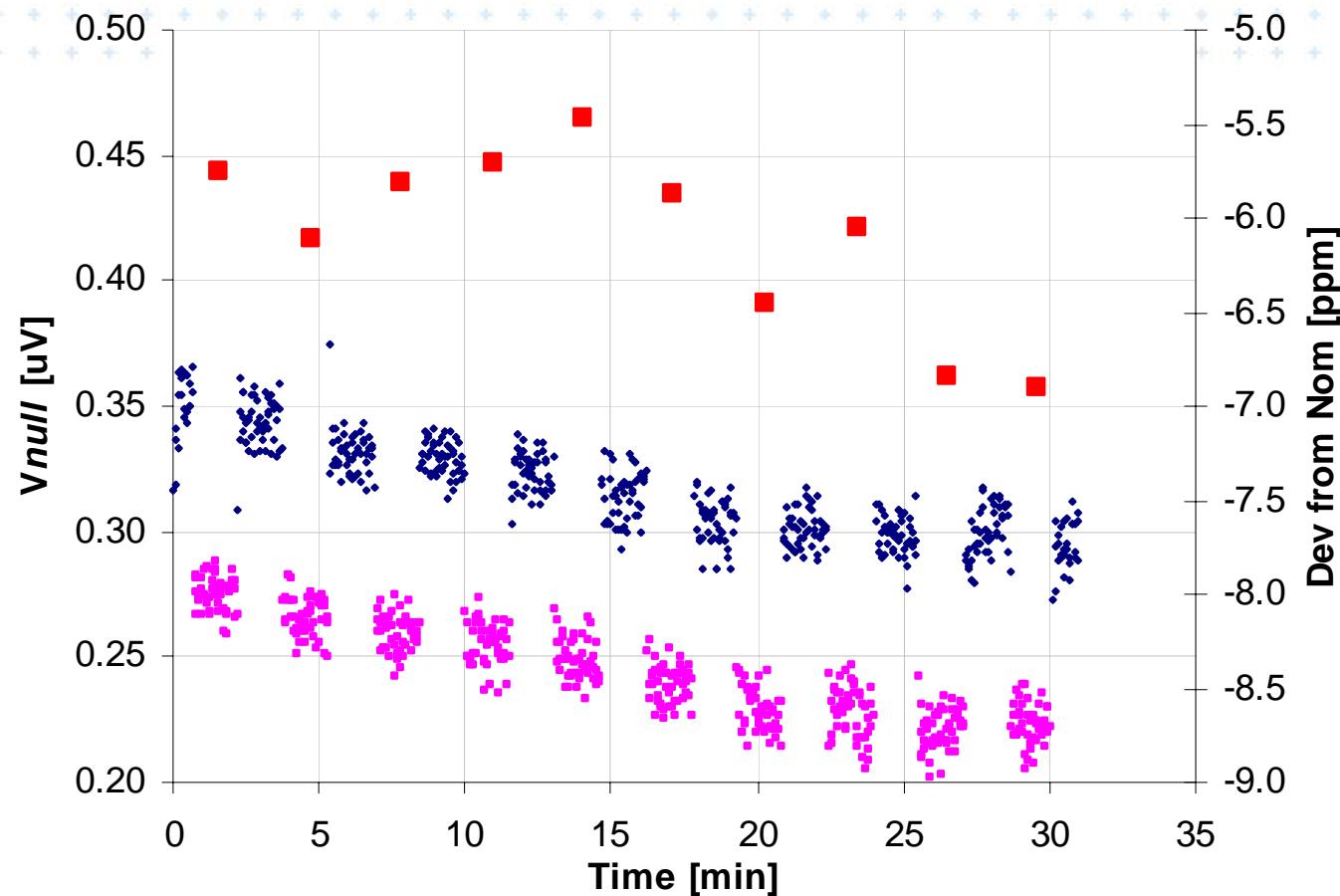
Based on MIL6000A extender + HP34420 nV-meter



$$R_x = \frac{R_s}{r} + \frac{V_{null}}{I_x}$$

VSL set-up

Advantages: Automated, Insight in process,
Lower uncertainty



Uncertainty budget

$$R_x = \frac{R_s}{r} + \frac{V_{\text{null}} + \delta V_{\text{cal}} + \delta V_{\text{th}}}{(I_s + \delta I_{\text{cal}} + \delta I_0) \cdot r}$$

$$R_x = \frac{R_s}{r} + \frac{V_{\text{null}}}{I_x}$$

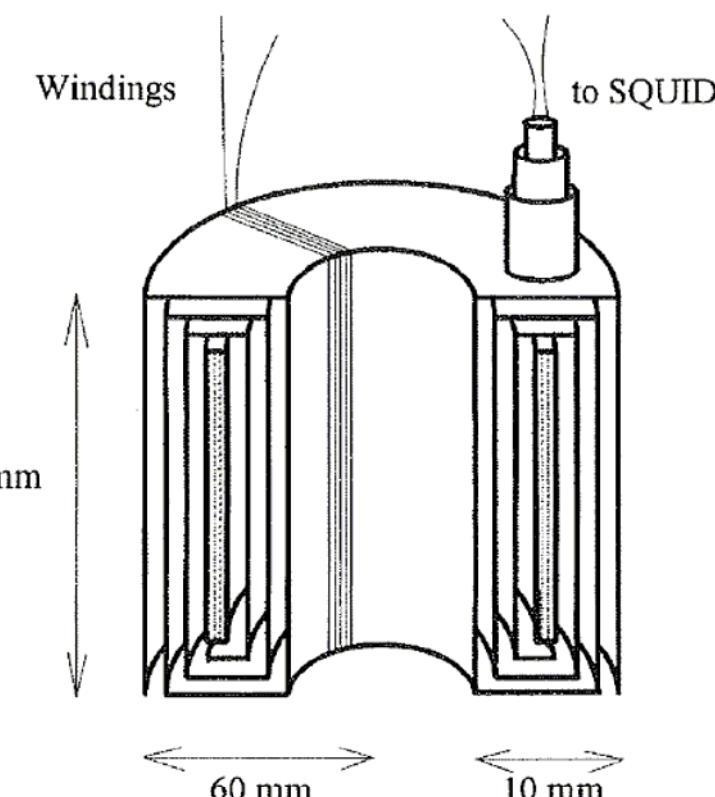
Quantity	Value	Standard Uncertainty	Distr.	Sens. Coef.	Uncertainty Contribution
R_s	0.1Ω				
r	1000	$58 \cdot 10^{-6}$	rect	$-0.10 \cdot 10^{-6} \Omega$	$-5.8 \cdot 10^{-12} \Omega$
V_{null}	139 nV	1.00 nV	normal	0.033 A^{-1}	$33 \cdot 10^{-12} \Omega$
δV_{cal}	0.0 V	1.15 nV	rect	0.033 A^{-1}	$38 \cdot 10^{-12} \Omega$
δV_{th}	0.0 V	0.58 nV	normal	0.033 A^{-1}	$19 \cdot 10^{-12} \Omega$
I_s	-0.03 A	$1.30 \mu\text{A}$	normal	$150 \cdot 10^{-9} \text{ VA}^{-2}$	$0.2 \cdot 10^{-12} \Omega$
δI_{cal}	0.0 A	$0.5 \mu\text{A}$	normal	$150 \cdot 10^{-9} \text{ VA}^{-2}$	$0.08 \cdot 10^{-12} \Omega$
δI_0	0.0 A	$38.1 \mu\text{A}$	normal	$150 \cdot 10^{-9} \text{ VA}^{-2}$	$5.9 \cdot 10^{-12} \Omega$
R_x	$100.00463 \mu\Omega$	Exp. Unc. $1.1 \cdot 10^{-6}$ (relative $k=2$)			

Uncertainty CMC: $0.2 \mu\Omega/\Omega - 1.5 \mu\Omega/\Omega$ for $0.1 \Omega - 0.1 \text{ m}\Omega$
 Cross-checks: closure 1–0.01–0.1–1: $(0.03 \pm 0.08) \mu\Omega/\Omega$

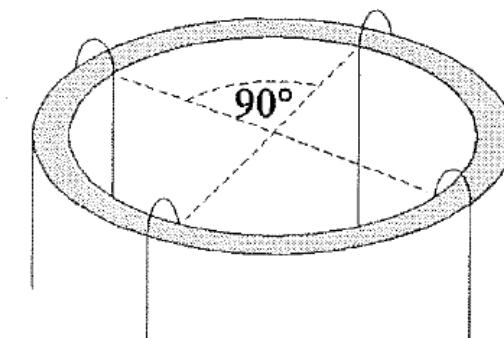
NPL set-up: CCC

CCC type II

windings 1 – 1000, binary built-up
 $12 \text{ mA t} / \Phi_0 - 2 \mu\text{A}/\sqrt{\text{Hz}}$



Rope	Windings (no. turns)
100 A, 2 × 1T	1, 1
15 strands, 1T	1, 2, 4, 8
15 strands, 8T	8, 16, 32, 64
15 strands, 125T	125, 250, 500, 1000



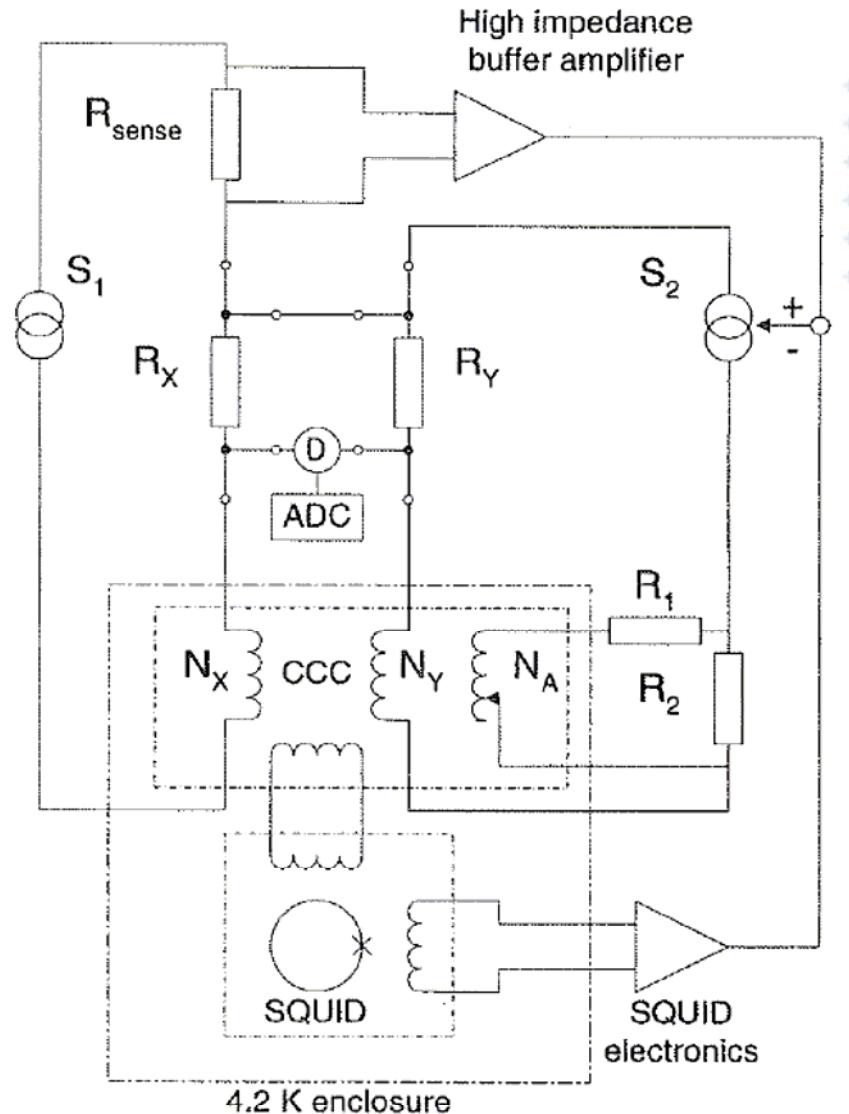
TEST OF CCC SHIELD ACCURACY

Error in 0° plane	E_1	6.3×10^{-9}
Error in 90° plane	E_2	2.2×10^{-9}
Total maximum error	$(E_1^2 + E_2^2)^{1/2}$	6.7×10^{-9}

NPL set-up: bridge

'Standard' CCC bridge

- Null detector:
EM model P13
($130 \text{ pV}/\sqrt{\text{Hz}}$)
- Uncertainty:
 $0.85 \mu\Omega/\Omega$ at $1 \text{ m}\Omega$



NPL set-up: power test

LOW POWER RESISTANCE MEASUREMENTS

$R_Y : R_X$	$N_Y : N_X$	$I_X (A)$	$P_X (mW)$	$\sigma (\mu\Omega/\Omega)$
$1 \Omega : 100 m\Omega$	$1000 : 100$	0.1	1	0.03
$1 \Omega : 1 m\Omega$	$1000 : 1$	3.0	9	0.10
$100 m\Omega : 100 \mu\Omega$	$1000 : 1$	10.0	10	0.21

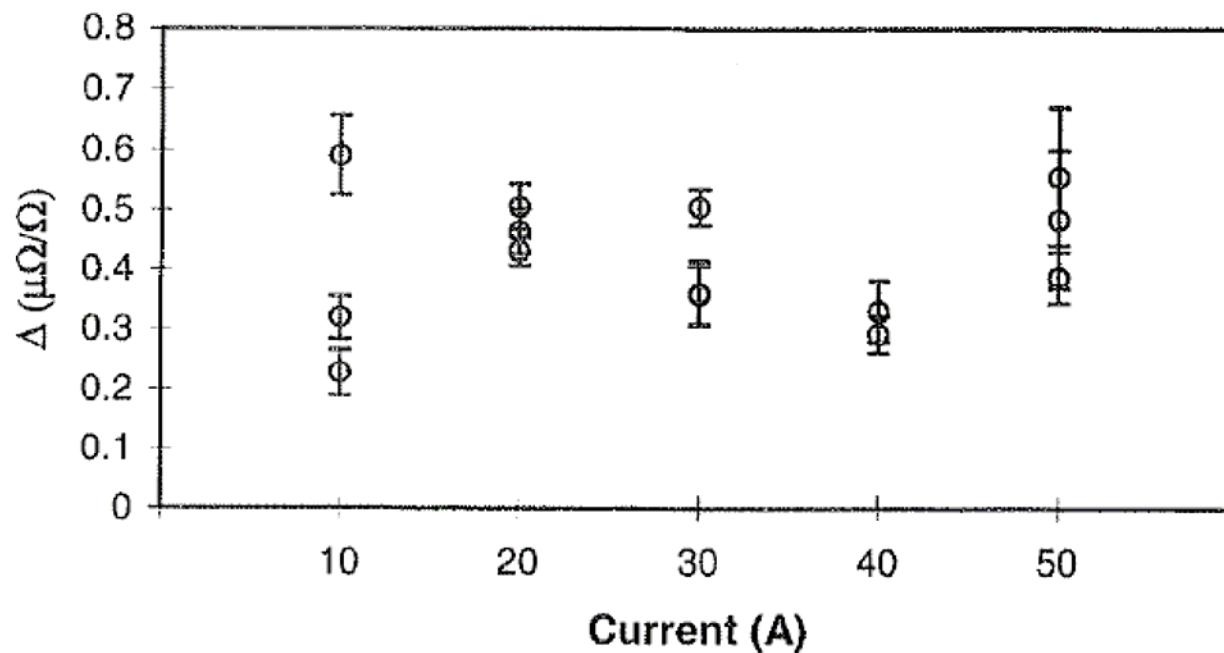


Fig. 6. $10 m\Omega$ resistor as a function of current, $R = 10[1 - (92 \times 10^{-6} + \Delta)] m\Omega$.

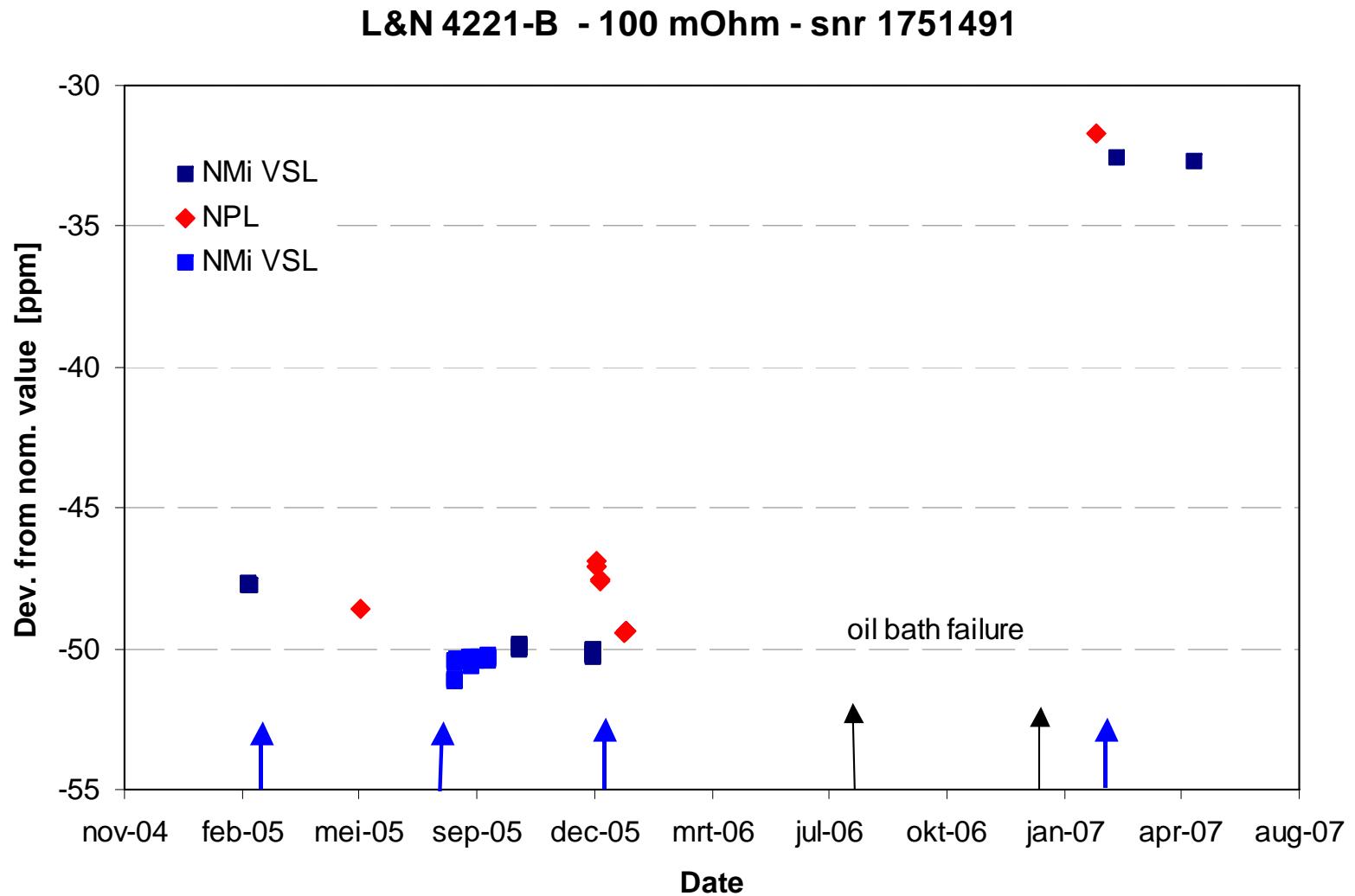


Low ohmic comparison

Aim: provide independent evidence for CMC entries in resistance $< 1 \Omega$

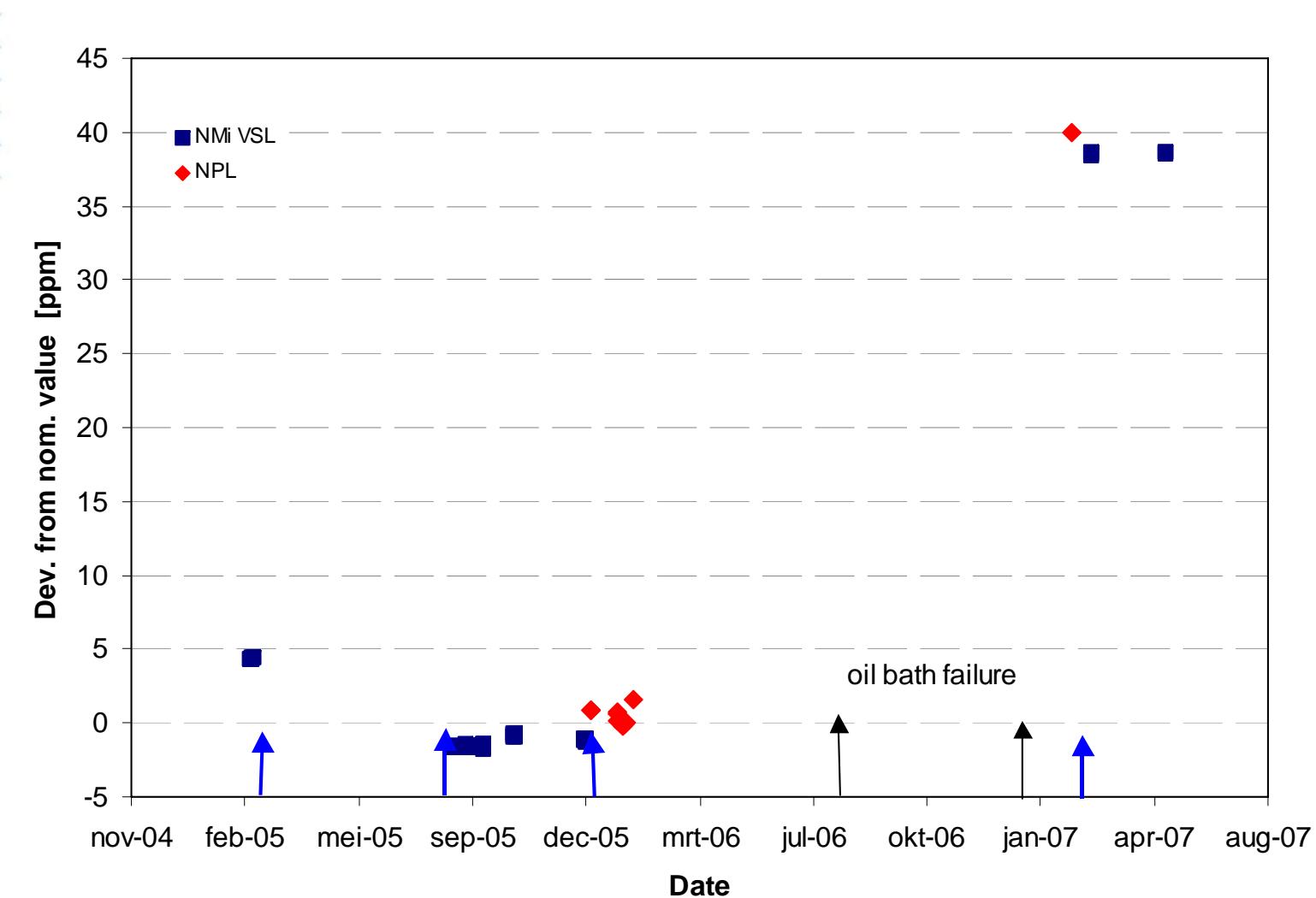
- Compare bridge based on RT comparator (NMI VSL) with 100 ampere CCC (NPL)
- Travelling behaviour of low-ohmic resistors
- Four L&N 422X-B resistors ($100 \text{ m}\Omega$, $10 \text{ m}\Omega$, $1 \text{ m}\Omega$, $100 \mu\Omega$)
- Measurement in oil, 23°C
- Measurements at different power levels

100 mΩ resistor

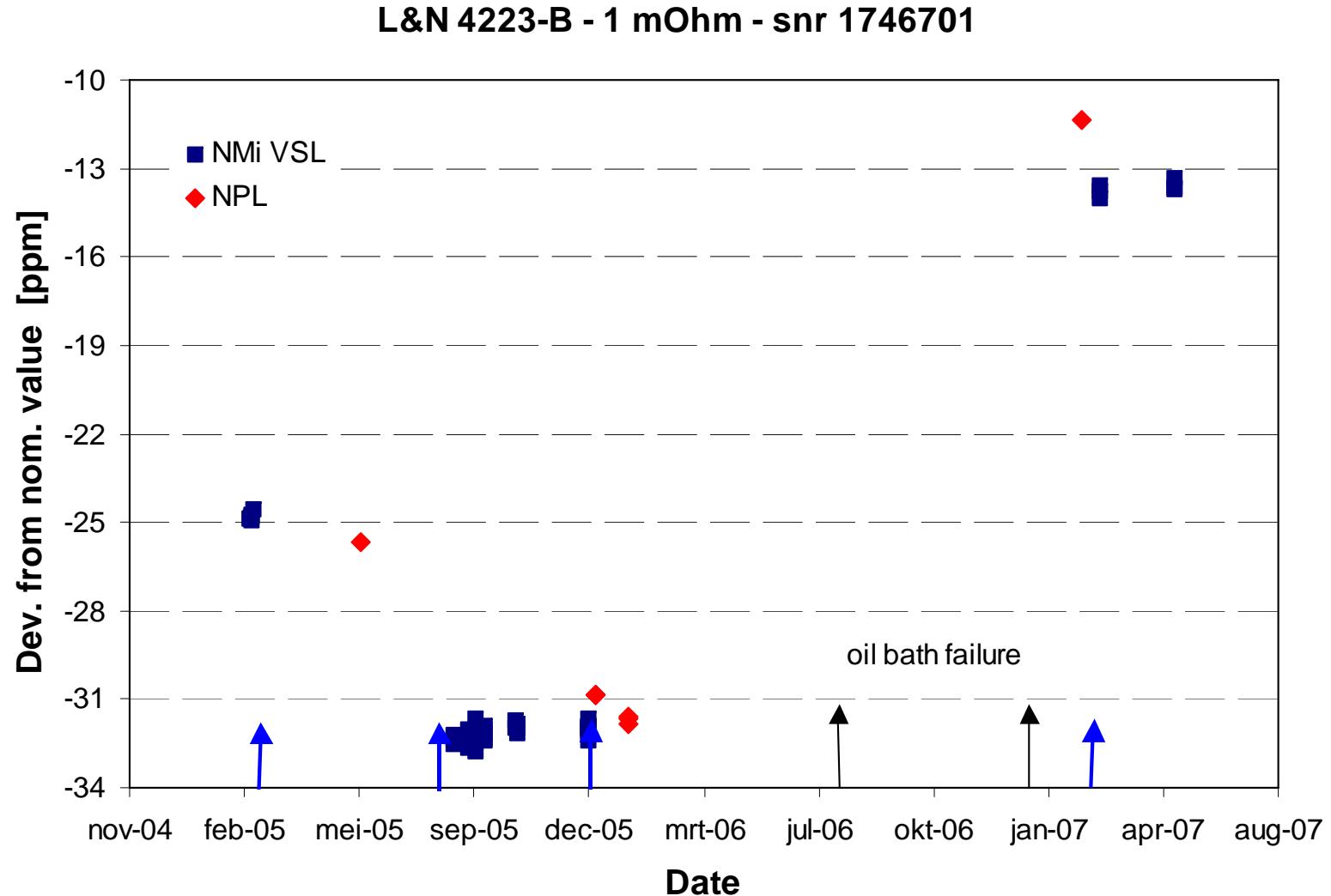


10 mΩ resistor

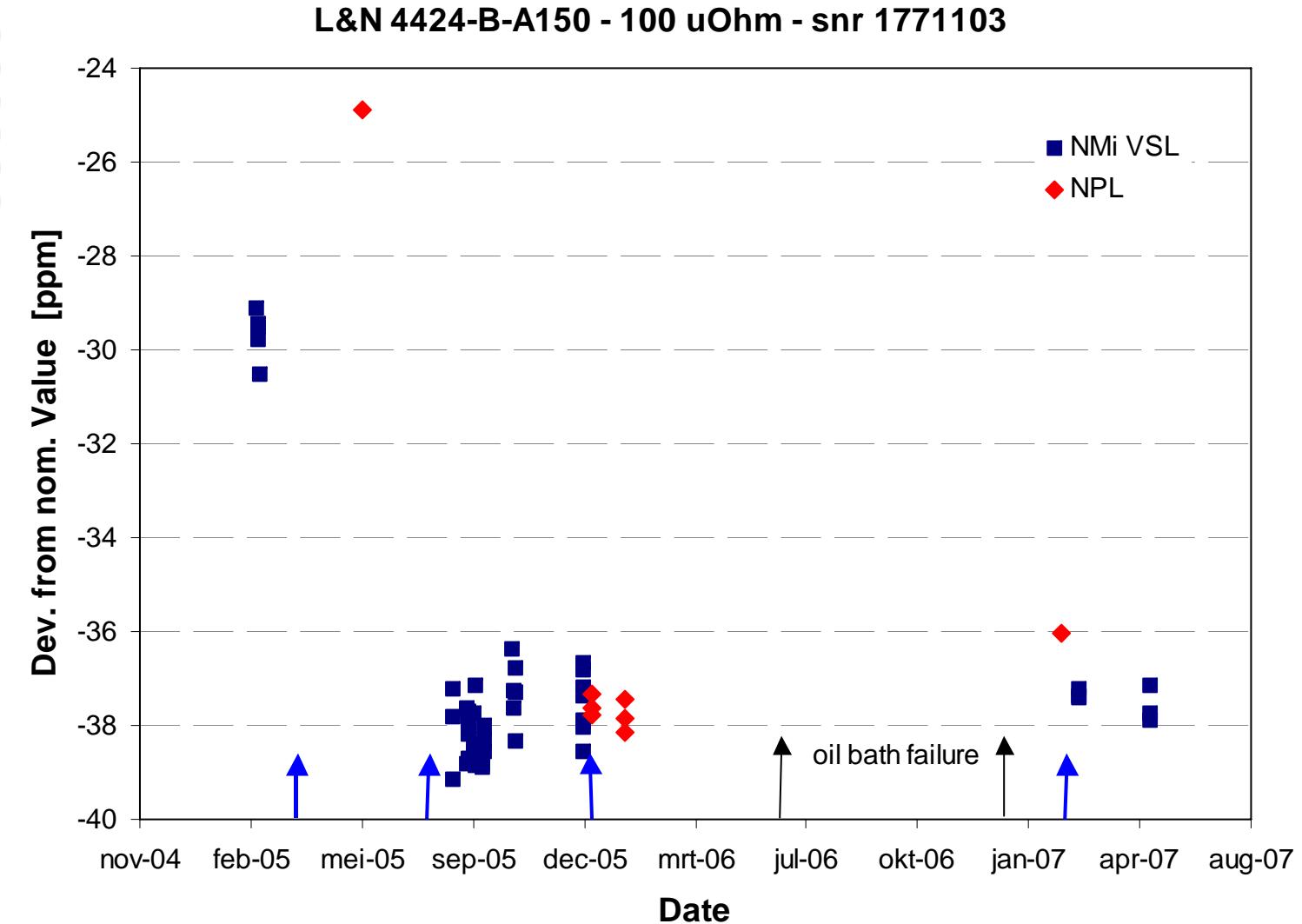
L&N 4222-B - 10 mOhm - snr 1750182



1 mΩ resistor



100 $\mu\Omega$ resistor



Preliminary conclusions

- NL – UK travelling behaviour is reasonable but not ideal (few ppm)
- Large temperature excursions have huge effects on the resistance value
→ shifts up to 40 ppm

The travelling resistors seem to be the limiting factor in the comparison

Compare 1 – 3 ppm ↔ 0.1 – 1.5 ppm CMCs



Outlook & discussion

- How independent are measurement methods? (RTCCs + range extenders)
- Uncertainty sources?
- Required cross-checks?

- How should comparison proceed?
→ better resistors needed!

NMI VSL setup: IEEE I&M 2007, **56**, pp. 406 - 409

NPL setup: IEEE I&M 1999, **48**, pp. 375 - 378